




Computer Memory Test Labs : Intel Advanced Final Report

<u>MOTHERBOARD</u>	<u>MANUFACTURER</u>	<u>CHIPSET</u>	<u>TEST NUMBER</u>	<u>TEST STATUS</u>				
SE7320VP2D2	Intel	Intel E7320	011813	PASSED				
<u>MODULE INFORMATION</u>				<table border="1" style="width: 100%;"> <tr> <td style="text-align: center;">Certified</td> <td style="text-align: center;">CRL</td> </tr> <tr> <td style="text-align: center;"></td> <td style="text-align: center; font-size: 24px;">5</td> </tr> </table>	Certified	CRL		5
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<p>Manufacturer Name: Smart Modular Technologies</p> <p>Part #: SG1287RDR212435NA</p> <p>MB: 1GB Cas Latency: 3</p> <p>Config: 128M x 72 Assembly: Single Board/Non St</p> <p>DRAM: Nanya Low Profile: Yes</p> <p>DRAM Part #: NT5TU128M4AE-5A rev A Register Part #: UF32864EHLF</p> <p>PCB Part: NTPCB00019P PLL Part #: ULP877BHLF</p> <p>PCB_layer_count: 8 Layer Dual Die Package Support <input type="checkbox"/> Bank 1</p> <p>Module Info: Registered ECC 400Mhz DDR2 DIM Environment Code RoHS</p>								
<u>PRE-TESTING INFORMATION</u>		<u>MINIMUM SYSTEM INFORMATION</u>		<u>MAXIMUM SYSTEM INFORMATION</u>				
Board Revision: D10582-201	Minimum System: SE7320VP2D2	Maximum System: SE7320VP2D2						
Insertion Test: Pass	Serial Number: QSV251500022	Serial Number: QSV251500032						
SPD Status: Pass	Bios at time of test: SE7320VP21.86B.P.07.00.0037	Bios at time of test: SE7320VP21.86B.P.07.00.0037						
Power Cycle Stat: Pass	Processor Code: Xeon 3.6Ghz 800Mhz x 2	Processor Code: Xeon 3.6Ghz 800Mhz x 2						
Power Cycle Time: 109	Memory Count : 2048	Memory Count : 6144						
	Event Log Verify: Clear	Event Log Verify: Clear						
	OS Memory Count: 2GB	OS Memory Count: 6GB						
	OS/Service Pack: Win2003 Server	NA	OS/Service Pack: Win2003 Server					
	Disk Man: Hitachi	Disk Man: Hitachi						
	Disk Capacity: 82.3GB	Disk Capacity: 64.1GB						
	Disk Serial #: S2RJBBGB	Disk Serial #: C2SYJN0P						
<u>TESTING DETAILS FOR PHASE 1</u>		<u>TESTING DETAILS FOR PHASE 2</u>		<u>TESTING DETAILS FOR PHASE 3</u>				
Ambient Temperature : Standard Voltage		55°C Temperature : 1.69 (- 6 %) Volts		55°C Temperature : 1.90 (+ 6 %) Volts				
Start Date:		Start Date: 7/5/06		Start Date: 7/5/06				
Stop Date:		Stop Date: 7/7/06		Stop Date: 7/7/06				
Min MCFT Test Status: N/A	Min WINPIE Test Status: Pass	Min WINPIE Test Status: Pass						
Max MCFT Test Status: N/A	Max WINPIE Test Status: Pass	Max WINPIE Test Status: Pass						
SEL/Outrider Min:	SEL/Outrider Min: Pass	SEL/Outrider Min: Pass						
SEL/Outrider Max:	SEL/Outrider Max: Pass	SEL/Outrider Max: Pass						
	Summary Min: Pass	Summary Min: Pass						
	Summary Max: Pass	Summary Max: Pass						
Ph1 Package: N/A	Ph2 Package1: WinPIE 4.30	Ph3 Package1: WinPIE 4.30						
Test Phase Status: N/A	Test Phase Status: Pass	Test Phase Status: Pass						
Single Bit Errors <input type="checkbox"/>								
QTY:								
<u>VENDOR CONTACT INFORMATION</u>								
Contact:	Contact Phone:	Purchase Order #:						
Jim Schwarz		06/22/06						
Test Traveler Notes:				CMTL USE ONLY:				
VM Data @ EEPROM # 016, 33, 002 & 015, 28, 002.				Verified by:				
				Emailed by:				

Test Technician: Thanh Nguyen

In the event of a module failure, CMTL is not required to provide root cause analysis. Accuracy of testing is restricted to the above mentioned module with specific DRAM, PCB and other components as listed and tested with the CMTL Memory Compatibility. Functionality Test, Microsoft Advanced Server 2000®, Windows NT 4.0 Enterprise Edition®, Windows XP® Windows 98 SE®, Dos 6.22®, MSTRESS® (v x.x), XLINEAR® (v x.xx), FXLINEAR® (v x.xx), Patin® (v x.x), WinMTA® (v x.xx). (Voltage margining applied only to those systems that are applicable.)

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